Sheet	1	of	11

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·L	1	ē_	1	7	5	5	4	3	12/1992	Lantz	$\Lambda$			
1	2.	5	4	ı	2	3	8	4	5/1995	Chang et al.				
	3.	4	8	7	2	0	0	9	10/3/89	Tsukiyama et al.				
	4.	4	9	2	9	9	4	6	5/29/90	O'Brien et al.		1		
	5.	δ	þ	4	5	8	5	2	9/3/91	Mitchell et al.		$\overline{1}$		
	6.	5	b	9	7	2	6	1	3/17/92	Langdon, Jr. et al.		$\perp$		
	7. ·	5	2	1	2	7	4	2	5/18/93	Normile et al.		1		
	8.	5	2	3	1	4	þ	2	7/27/93	Dangi et al.		$\bot$		
	9.	5_	2	4	3	3	4	8	9/7/93	Jackson				
	10.	5	2	7	b	8	3	2	12/14/93	Balkanski et al.	<u> </u>		1	
	11.	5_	3	7	9	b	3	6	1/3/95	Storer			1	
<u> </u>	12.	5	3	8	1	1	4	<u>þ</u>	1/10/95	Allen et al.				
<u> </u>	13.	5	3	9	<u>k</u>	5	3	4	2/29/95	Kulakowski et al.	_		11	
	14.	5	4	6	<u>lı</u>	6	7	þ	10/24/95	Normile et al.				
	15.	5_	4	7	9	Þ	8	<u> </u>	12/26/95	Campbell et al.				
<u> </u>	16.	5_	4_	8	6	8	2	6	1/23/96	Remillard	$\perp$			
	17.	<u> </u>	<u>k</u>	9	5	2	<u> </u>	<u>k</u>	2/27/96	Je-chang et al.	$\perp$			· · · · ·
	18.	<u>5</u>	5	3	3	6	5	1	7/2/96	James	<u> </u>			
	19.	<u> </u>	<u> </u>	3	3_	5	┢	þ	12/10/96	Allen et al.	$\perp$			
#N	20.	5_	6_	5_	4	7	b	3	8/5/97	Clark, II				
1/	<u> </u>		Ļ				_				· _		\	······································
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EXAMINER: Initial if/citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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The	21.	5	6	6	8	7	3	7	9/16/97	Iler				
1	22.	<u>Б</u>	7	1	7	3	9	4	2/10/98	Schwartz et al.				
	23.	δ	7	2	9	2	2	8	3/17/98	Franaszek et al.				
	24.	Б	7	4	8	9	0	4	5/5/98	Huang et al.				
	25.	5	7	7	1	3	4	0	6/23/98	Nakazato et al.		1		
	26.	<u>5</u>	7	8	4	Þ	7	2	7/21/98.	Rostoker et al.				
	27. ·	5	8	o	Б	9	3	2	9/8/98	Kawashima et al.				
	28.	Б	8	1	8	3	6	8	10/6/98	Langley		- 1		
	29.	5	8	1	8	Þ	3	0	10/6/98	Canfield et al.				
	30.	5	8	2	Б	4	2	4	10/20/98	Canfield et al.			\	
	31.	5	8	4	7	7	6	2	12/8/98	Canfield et al.				
	32.	5	8	6	1	8	2	4	1/19/99	Ryu et al.				•
	33.	5	9	1	7	4	3	8	6/29/99	Ando		•		
	34.	5	9	6	4	8	4	2	10/12/99	Packard				
	35.	5	9	9	1	5	1	5	11/23/99	Fall et al.				
	36.	6	0	3	1	Ģ	3	9	2/29/00	Gilbert et al.				
	37.	5	8	3	9	1	o	þ	11/1998	legener .				
	38.	6	1	4	1	0	5_	3	10/2000	Saukkonen				
	39.	4	6	8	2	1	5	0	7/1987	Mathes et al.				
	40.	5	2	3	7	6	7	5	8/1993	Hannon, Jr.				
	41.	5	5	5	7	7	4	9	9/1996	Norris				
	42.	6	5	2	9	6	3	3	3/2003	Easwar et al.				
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EXAMINER: Initial of citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Form PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  INFORMATION DISCLOSURE STATEMENT BY APPLICANT  E several sheets if necessary)	ATTY. DOCKET NO. 8011-1 CIP CON	SERIAL NO. 10/668,768
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W.	43.	4	7	<u>5</u>	4	3	5	h	3/1986	Dang et al.	1			
ls^	44.	4	8	0	4	9	Þ	9	2/2989	Makansi et al.		\		
	45.	4	8	7	. o	4	1	Б	9/1989	Van Maren et al.		$\int$		
	46.	4	þ	6	5	6	7	5	10/1990	Hori et al.		1	<u></u>	
	47.	5	<u>6</u>	k P	8	9	2	2	7/1991	Huang		1		
	48.	5	0	4	6	b	2	7	9/1991	Taaffe et al.		1		
	49.	5	lı.	5	o_	4	3	O	9/1992	Chu				
	50.	5_	1	5_	9	3	3	6	10/1992	Rabin et al.				
	51.	Ď	1	7	9	6	Б	1	1/1993	Taaffe et al.				
	52.	5	2	3	7	4	6	þ	8/1993	Miller et al.				•
	53.	5	2	3	7	6	7	5	8/1993	Mannon, Jr.				
	54.	5	2	4	7	6	3	8	9/1993	O'Brien et al.				
	55.	5_	2	4	7	6	4	6	9/1993	Osterlund et al.				
	56.	δ	2	8	7	4	2	0	2/1994	Barrett				
	57.	5	3	5	7	6	1	4	10/1994	Pattisam et al.				
	58.	Þ	4	1	4	8	5	0	5/1995	Whiting				
VA /	59.	5	5	þ	6	8	7	2	4/1996	Mohler				
Jan.	60.	Б	5	3	Б	3	Б	6	7/1996	Xim et al.				
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7														<u> </u>

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$\mathcal{L}$	61.	5	5	3	7	ß	Б	В	7/1996	Bakke et al.	-   \			
, N	62.	5	Б	6	1	8	2	4	10/1996	Carreiro et al.				
	63.	5	Б	7	4	9	Б	2	11/1996	Brady et al.				
$\Box$	64.	5	5	7	4	9	5	3	11/1996	Rust et al.	\	Ш		
	65.	<b>5</b>	5	9	b	3	0	6	12/1996	Watanabe et al.		П		
	66.	5	6	þ	6	7	0	6	2/1997	Takamoto et al.		Ш		
	67.	5	6	1	5	o	1	7	3/1997	Choi et al.		Ш		
	68.	5	6	2	1	8_	2	þ	4/1997	Rynderman et al.		-\		
	69.	5	6	2	3	6	2	3	4/1997	Kim et al.				
	70.	5	6	2	3	7	o	1	4/19 <del>9</del> 7	Bakke et al.				
	71.	Б Б	6	2	7	9	9	Þ	5/1997	Miller et al.	:			
	72.	5	6	2	9	7	3	2	5/1997	Moskowitz et al.				
	73.	5	6	3	0	0	9	5	5/1997	Carreiro et al.				
	74.	5 	6	5	2	8	5	7	7/1997	Shimoi et al.				
	75.	5	6_	] 5_	2	þ	1	7	7/1997	Maupin e tal.				
	76.	5	6	<u>.</u>	5	1	3	8	8/1997	Kikinis				
	77.	5	6	6	6	5	6	b	9/1997	Moertl et al.				
	78 <b>.</b> .	5	6	7	1	3	8	9	9/1997	Saliba				
	79.	<u> </u>	<u>k</u>	9	4	6	1	9	12/1997	Konno				
	80.	5	6	9	6	9	2	7	12/1997	MacDonald et al.				
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di	81.	5	7	1	5	4	7	7	2/1998	Kikinis				
/x	82.	5	7	2	1	9	5	8	2/1998	Kikinis				
0	83.	ō	7	2	4	4	7	Þ	3/1998	Xirsten				
	84.	5	7	7	8_	k	1	h_	7/1998	DeMoss et al.		1_		
	85.	<u>5</u>	7	8	7	<u>k</u>	8	7	7/1998	Hashimoto et al.		$\bot$		
	86.	5	В	<u>6</u>	8	6	6	b	9/1998	Sekine et al.		$\bot$		
$\perp$	87.	5	В_	þ_	þ	3	3	7	9/1998	Hannah et al.	_	$\perp$		
	88.	5	8_	1	2	<u> </u>	8	9	9/1998	Diaz		$\perp$		
	89.	5	В	<u> </u>	8	þ	9	6	11/1998	deCarmo				
	90.	<u> </u>	8_	<u>ķ</u> .	1	þ	7	þ	11/1998	Schulhof et al.				
	91.	<u>5</u>	8	4	7	7	6	2	12/1998	Canfield et al.	L			
	92.	5	8	7_	b	þ	8	7	2/1999	Chau	L		:	•
$\perp$	93.	5_	8_	8_	9	9	6	1	3/1999	Dobbek			<b> </b>	
	94.	<u> </u>	9	1	<u> </u>	þ	7	9	6/1999	Vondran, Jr. et al.	_		<u> </u>	
	95.	5	9	3_	6	6	1	6	8/1999	Torborg, Jr. et al.	Ŀ		<b> </b>	
	96.	δ	9_	6_	b	4	6	<u> </u>	9/1999	Adams	L		<u> </u>	
	97.	<u> </u>	9	6	8	1	<u> </u>	9	10/1999	Jaquette et al.	L			•
	98.	<u> </u>	9	7 .	4	ķ.	7	1	10/1999	Belt	L			
4	99.	<u> </u>	9	9_	6	þ	3_	3	11/1999	Chiu-Hao			$\vdash \downarrow$	
1	100.	6	0	0	0	þ	0	9	12/1999	Brady			oxdot	
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-d	101.	ß	þ	0	2	4	1	Ī	12/1999	Dye	1			
2/	102.	6	þ	1	1	9	0	1	1/2000	Kirsten				
	103.	6	b	1	4	6	9	4	1/2000	Aharoni et al.		$T_{-}$		
	104.	6_	þ	2	6	2	1	7	2/2000	Adi letta ·		$\mathcal{I}$		
	105.	6	þ	2	8	7	2	5	2/2000	Blumenau				
!·	106.	6	þ	3	2	1	4	8	2/2000					
	107.	4	þ	5	3	3	þ	4.	06/1986	Ohkubo et al.				
	108.	5	6	6	4	8	2	4	02/1997	Chui et al.				
	109.	5	6	1	2	7	8	8	03/1997	Stone			<b>\</b>	
	110.	Þ	8	1	9	2	1	Þ	10/1998	Dobson et al.			1	
	111.	5_	8	3	2	1	2	6	11/1998	Tanaka, Kimiyuki	ľ	• •		
	112.	6	5	9	0	6	0	þ	07/2003	Kitade et al.				
	113.	6	4	3	4_	1	6	8	08/2002	Xari				
	114.	6	2	Ь	3	2	6	4	06/2001	Sebastian	ŀ			
•	115.	5_	8	7	0	þ	3	6	2/1999	Franaszek et al.		•		
	116.	5	В	8	3	9	7	5	3/1999	Narita et al.				
	117.	5	9	<u>Б</u> .	5	9	7	6	9/1999	Heath				
	118.	6	4	8	9	9	9	2	12/2002	Heath				
^	119.	4	Б	7	4	3	Б	1	3/1986	Dang et al.				
dr	120.		<b>U.</b> :	; <u> </u>	Pat	ent:	<u>P</u> u	blio	cation No. U	S 2003/0142874 07/2003 Schwartz, Edward L.				\
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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EXAMINER INITLALS	Ref.#		DOC	LOME	NT	NUX	BER		DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	121.	ķ	7	3	þ	В	4	8	3/1998	MacCrisken			
Q	122.	4	9	0	6	9	9	Þ	3/1990	Swanson			
1	123.	Ď	þ	4	9	8	8	1	9/1991	Gibson et al.			
	124.	5	4	0	6	2	7	8	4/1995	Graybill et al.			
	125.	β	8	3.	2	р	3	7	11/1998	Park			
	126.	5	8	3	2	1	2	6	11/1998	Tanaka			
	127.	5	9	7	3	6	3	þ	10/1999	Heath			
	128.	ß	3	,	7	7	1	4	11/2001	Del Castillo et al.			
	129.	В	6	þ	6	4	1	3	8/2003	Zeineh, Jack A.		<u> </u>	
	130.	б	5	4	2	6	4	4	4/2003	Satoh, Noriko		1	
	131.	6	1	2	8	4	1	2	10/2000	Satoh, Noriko			•
	132.	6	p	9	4	6	3	4	7/2000	Yahagi et al.			
	133.	Ь	b	7	5	4	7	b	6/2000	Little et al.			
	134.	б	6	6	1	B	,	T	5/2000	Satoh et al.			
	135.	Б	В	В	6	6	5	T	3/1999	Rust, Robert A.			
	136.	5		1	2	Б	3		2/1999	Domyo et al.			
	137.	5	1	5	7	8	Б	T	05/1998	Kericevic et al.			<del></del>
	138.	5		0	3	Ţ	9	3	12/1997	⊮ise et al.			
		5	t –	4	,	6	3	1	7/1997	Burt et al.			
	140.	5		b	6	2	7	1	4/1995	Anderson et al.			
		Б	T	0	4	7	Б	Т	4/1993	Chevion et al.			·
			F	Т	6	Ė	4	Ī	10/1989	Storer, James A.			
			┰	-		7	<del>,</del>	ļ.	11/1981	Vidergren et al.		1	
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Sheet <u>8</u> of <u>11</u>

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EXAMINER INIZJIALS	Ref.#		DOC	CUME	ENT	NUX	IBER		DATE	NAME	اعِ	LASS	SUBCLASS	FILING DATE IF APPROPRIAT
7	144.	Б	Б	b	k	8	<b>k</b>	4	4/1996	Rao, R. Padmanabha	$\sqcap$			
4	145.	Б	3	b	6	<b>F</b>	Б	1	5/1 <del>99</del> 4	Akins et al.		<u> </u>		
(1)	146.	Б	1	8	7	7	9	3	2/1993	Keith et al.				
$\prod_{i=1}^{n}$	147.	5	2	2	6	1	7	6	7/1993	Westaway et al.		I		
	148	6	4	4	2	6	5	9	8/2002	B lumenau				
	149.	5	Б	3	0	8	ķ	5	6/1996	Hiatt				
	150.	5_	6	5	2	8	5	7	7/1997	Shimoi et al.		$oldsymbol{\perp}$		
	151.	<u> </u>	<u> </u>	5	7	6	1	4	10/1994	Pattism ét al.				
	152.	6	1	4	5	þ	6	9	11/2000	Dye, Thomas A.			<b>\</b>	
	153.	5_	1	8	7	7	9	3	2/1993	Simon et al.			1	
<b> </b>	154.	6_	þ	7.	3	2	3_	2	6/2000	Kroeker et al.				
	155.	6	1	7	3	3	8	1	1/2001	Dye, Thomas A.	<u> </u>			
	156.	6	5	3_	þ	4	5	6	3/2003	Stewart, David C.	_			
	157.	6_	<u>k</u>	2	6	7	4	þ.	5/2001	Iga, Kazuhisa	_			
	158.	6_	2	2	6	6	6	7	5/2001	Matthews et al.	$\perp$		<u> </u>	<b>\</b>
\- <u>-</u>	159.	_	<u>þ.s</u>	s. I	ate	ent	Pub	lic	ation US-2002	/0126755 09-2002 Li et al.				1
1	160.	lacksquare	<u>þ.s</u>	s. I	ate	nt	Pub	lic	ation US-2002	/0104891 08-2002 Otto.				
1,	161.	_	<u>ψ.s</u>	S.	ate	ent	Pub	lica	ation US-2003	/0084238 05-2003 Okada et al.				
7/	162.			7,		nt.	Pub	lic	ation US-2002	/0037035 03-2002 Singh, Amit P.				

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1	163.	5	1	9	1	4	3		1	3/1993	Haseqawa et al.	1			
	164.	<u> </u>	6	7	5	3	3		3	10/1997	Boursier et al.	$\prod$			
	165.	6_	1	b	4	3	8		9	8/2000	Ando, Ichiro	$\prod$			
	166.	6	b	9	7	5	2		9	8/2000	Kadnier, Griffith W.	П			
	167.	5	9	8	2	7	k		3	11/1999	Kamatani, Yasuo				
	168.	ķ.	В	В	. 8	В	1		2	12/1989	Dinan et al.				
	169.	6	<u>ķ</u>	8	7	6	ķ		۵	11/2002	Lipasti, Mikko Herman		1		
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## FOREIGN PATENT DOCUMENTS

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